

Application/Control No.	

10/644,816 Examiner

Jason M. Han

Applicant(s)/Patent	under
Reexamination	

KAZI ET AL.

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ORIGINAL				CROS	S REFERENC	E(S)		
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Jason Han 11/22/2005 (Assistant Examiner) (Date)			L Huse tephen Hus			Total C	laims Allov G	ved: 16
(Legal Instruments Examiner)	/28/05 Dat <b>le</b> )		Mary Exam	iner II., (Da	/2005 le)	Print C	laim(s)	Print Fig.

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